

## §4. Topological Quantum Computation with Surface Codes

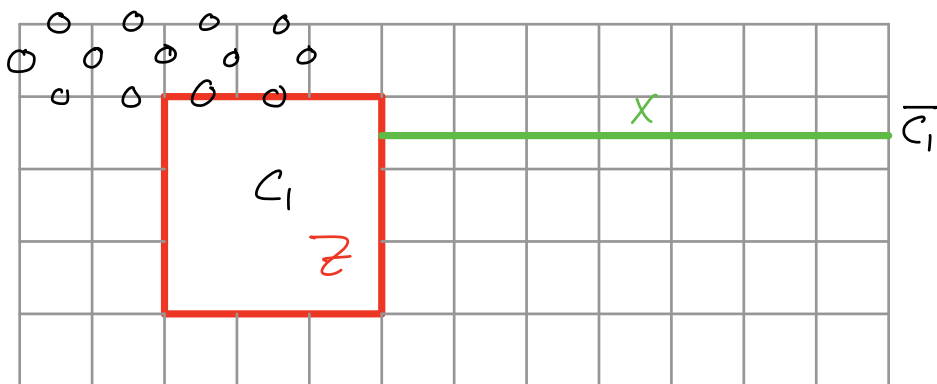
In this chapter we focus on the toric code model.

### §4.1 Defect Pair Qubits

In order to realize  $N$  qubits, we need a surface of higher genus

→ use a large planar surface and punch holes on it "defects"

→ logical operators are realized by cycle surrounding defect and chain connecting defect to boundary



Define two defect regions  $D \in C_2$  and  $D' \in C_2$

→ remove all  $Z$ -type stabilizers inside these regions, i.e.  $\{A_m\}_{p_m \in D \cup D'}$

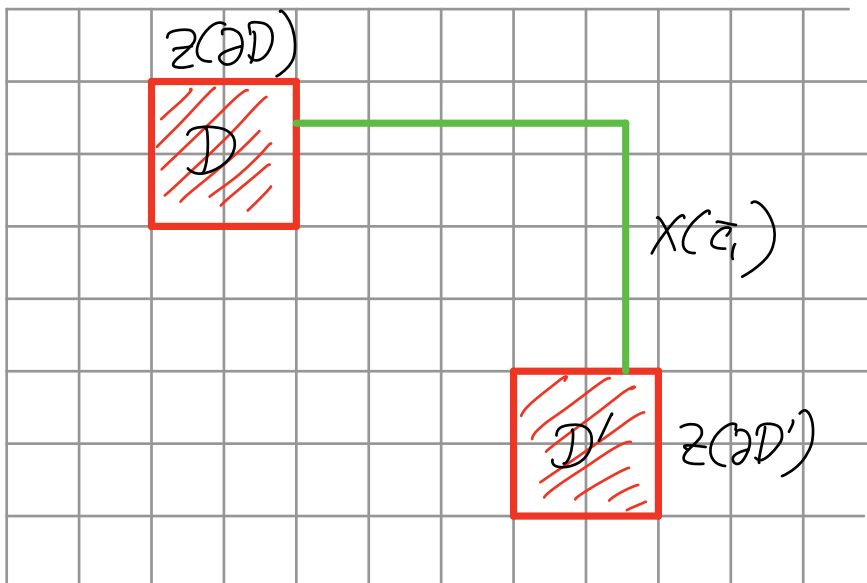
→  $Z(\partial D)$  and  $Z(\partial D')$  are not stabilizer operators

→ add  $Z(\partial D + \partial D')$  as stabilizer generator

→ choose  $Z(\partial D)$  as a logical operator

as  $Z(\partial D + \partial D')$  is stabilizer, we have

$$Z(\partial D) \sim Z(\partial D')$$

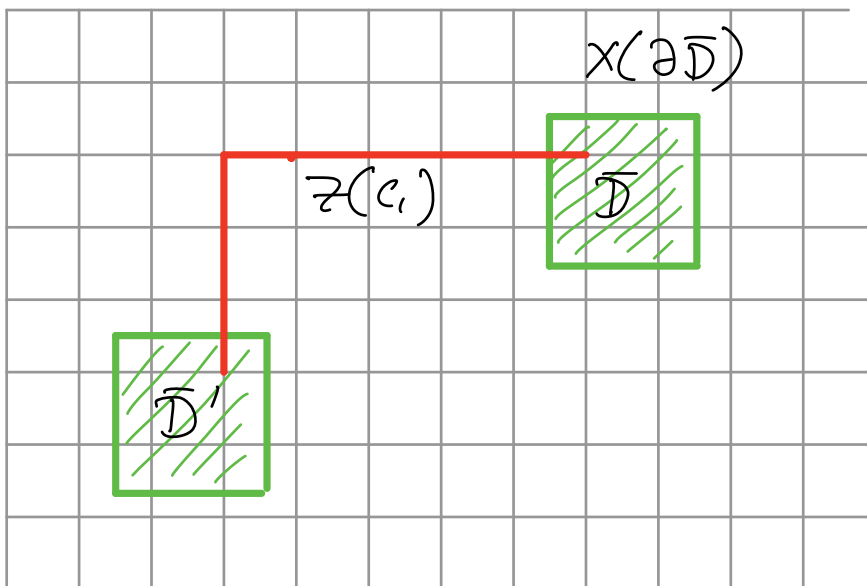


"primal defect pair qubit"

→ logical  $X$  operator is  $X(\bar{c}_1)$ , with  $\bar{c}_1$

connecting the two defects

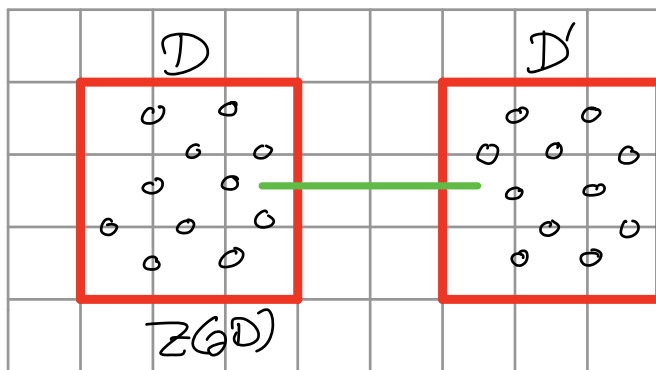
Similarly, we can also define a logical qubit by removing the star (X-type) stabilizers on dual defect regions  $\bar{D}$  and  $\bar{D}'$ :



"dual defect pair qubit"

## § 4.2 Defect Creation, Annihilation, and Movement

Defect creation is accomplished by measuring the qubits inside the defect region  $\bar{D}$  (not the boundary), in X-basis



→ measurement  
removes the  
plaquette operators  
inside  $D$  from  
stabilizer group  
( $[X, Z] \neq 0$ )

→ post-measurement state  
is given by  $|H\rangle$  for all measured  
qubits, stabilized by  $Z(D)$

→ do the same for region  $D'$

→ resulting state stabilized by  $Z(\partial D + \partial D')$

### Defect annihilation:

annihilation is executed by measuring  
plaquette operators inside region  $D$

→ restores to stabilizer group

namely, before measurement we have

$$|D\rangle \sim \prod_{e \in D} \left( \frac{I + X_e}{2} \right) |v\rangle$$

where  $|v\rangle$  indicates surface code without defect, i.e. vacuum

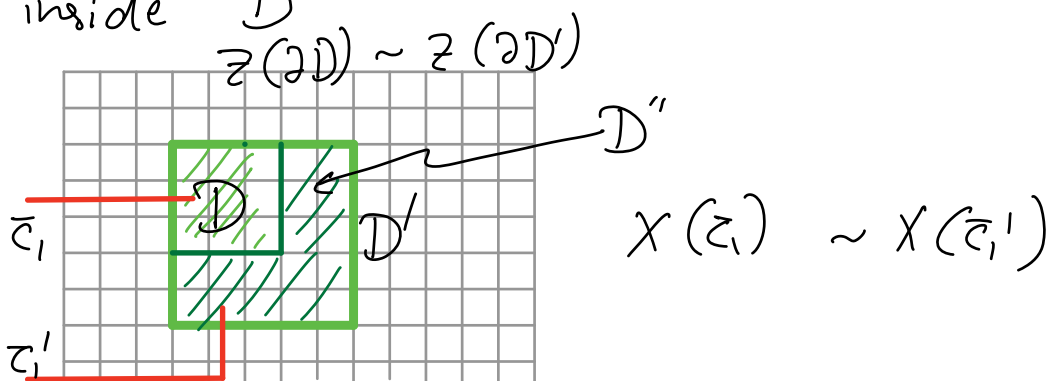
→  $|D\rangle$  is superposition of all possible  $X$ -op. applications

→ measurement of plaquette operators collapses superposition

→ parity of all measurement outcomes of plaquette operators inside  $D$  corresponds to eigenvalue of  $Z(\partial D)$ :

$$Z(\partial D) = \prod_{f \in \partial D} Z(f) = \prod_{f \in \partial D} A_f$$

Suppose defect region  $D$  inside  $D'$  is annihilated by measuring qubits inside  $D$



→ obtain eigenvalue  $(-1)^m$  of  $Z(\partial D)$

Let  $D''$  be complement of  $D$  in  $D'$

$$\text{as } Z(\partial D') = Z(\partial D'') Z(\partial D),$$

depending on the eigenvalue  $(-1)^m$ ,  
the operator  $(-1)^m Z(\partial D')$  acts as

logical operator of defect  $D''$

→  $D'$  is contracted into  $D''$   
(without changing stored  
quantum inf.)

Defect movement on surface is  
implemented by combining expansion  
and contraction:

